

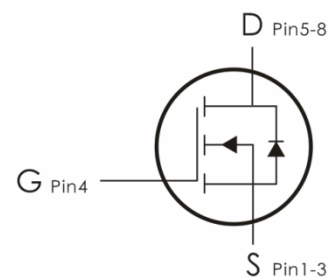
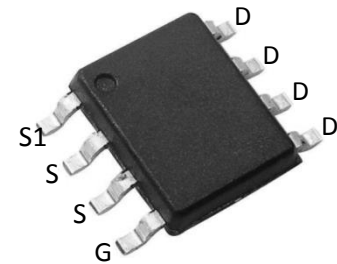
Description:

This N-Channel MOSFET uses advanced trench technology and design to provide excellent $R_{DS(on)}$ with low gate charge.

It can be used in a wide variety of applications.

Features:

- 1) $V_{DS}=30V, I_D=20A, R_{DS(ON)} < 6m\ \Omega @ V_{GS}=10V$
- 2) Low gate charge.
- 3) Green device available.
- 4) Advanced high cell density trench technology for ultra $R_{DS(ON)}$.
- 5) Excellent package for good heat dissipation.



Absolute Maximum Ratings: ($T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Ratings	Units
V_{DS}	Drain-Source Voltage	30	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Drain Current - Continuous ($T_C=25^\circ\text{C}$)	20	A
	Drain Current - Continuous ($T_C=100^\circ\text{C}$)	12.6	
I_{DM}	Drain Current - Pulsed ¹	80	
P_D	Power Dissipation ($T_C=25^\circ\text{C}$)	5.4	W
	Power Dissipation - Derate above 25°C	0.043	
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150	$^\circ\text{C}$

Thermal Characteristics:

Symbol	Parameter	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	23	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	85	

Package Marking and Ordering Information:

Part NO.	Marking	Package
MIC-SC006NG	C006N	SOP-8

Electrical Characteristics: ($T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\ \mu\text{A}$	30	---	---	V
$\Delta BV_{DSS}/\Delta T_J$	BV_{DSS} Temperature Coefficient	Reference to 25°C , $I_D=1\text{mA}$	---	0.04	---	$V/^\circ\text{C}$
I_{DSS}	Drain-Source Leakage Current	$V_{DS}=30V, V_{GS}=0V,$ $T_J=25^\circ\text{C}$	---	---	1	μA
		$V_{DS}=24V, V_{GS}=0V,$ $T_J=125^\circ\text{C}$	---	---	10	μA
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0V$	---	---	± 100	nA
On Characteristics						
$V_{GS(th)}$	GATE-Source Threshold Voltage	$V_{GS}=V_{DS}, I_D=250\ \mu\text{A}$	1.2	1.6	2.5	V
$\Delta V_{GS(th)}$	$V_{GS(th)}$ Temperature Coefficient		---	4	---	$\text{mV}/^\circ\text{C}$
$R_{DS(on)}$	Static Drain-Source On Resistance	$V_{GS}=10V, I_D=10A$	---	5	6	$\text{m}\Omega$
		$V_{GS}=4.5V, I_D=5A$	---	6.5	9	
G_{FS}	Forward Transconductance	$V_{DS}=10V, I_D=10A$	---	18	---	S
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{DS}=25V, V_{GS}=0V, f=1\text{MHz}$	---	1160	1900	pF
C_{oss}	Output Capacitance		---	200	400	
C_{rss}	Reverse Transfer Capacitance		---	180	360	
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time ^{2,3}	$V_{DS}=15V, I_D=15A,$ $R_{GEN}=3.3\ \Omega, V_{GS}=10V$	---	7.5	15	ns
t_r	Rise Time ^{2,3}		---	14.5	28	ns
$t_{d(off)}$	Turn-Off Delay Time ^{2,3}		---	35.2	60	ns
t_f	Fall Time ^{2,3}		---	9.6	19	ns

Q_g	Total Gate Charge ^{2,3}	$V_{GS}=4.5V, V_{DS}=15V,$ $I_D=20A$	---	11.1	22	nC
Q_{gs}	Gate-Source Charge ^{2,3}		---	1.85	3.7	nC
Q_{gd}	Gate-Drain "Miller" Charge ^{2,3}		---	6.8	13	nC
Drain-Source Diode Characteristics						
V_{SD}	Source-Drain Diode Forward Voltage ³	$V_{GS}=0V, I_S=1A, T_J=25^\circ C$	---	---	1	V
I_S	Continuous Source Current	$V_G=V_D=0V, \text{ Force Current}$	---	---	20	A
I_{SM}	Pulsed Source Current		---	---	40	A

Notes:

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
3. Essentially independent of operating temperature.

Typical Characteristics: ($T_C=25^\circ C$ unless otherwise noted)

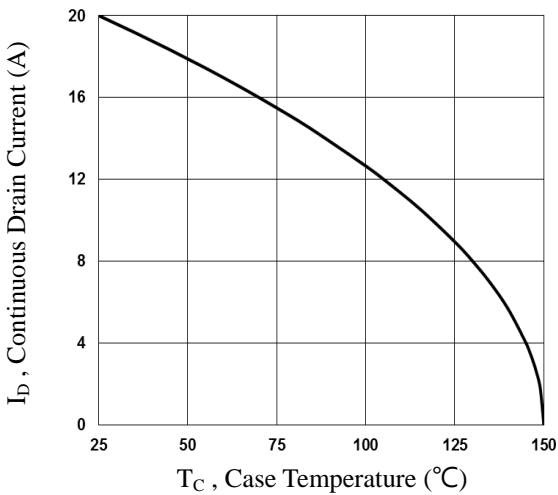


Fig.1 Continuous Drain Current vs. T_C

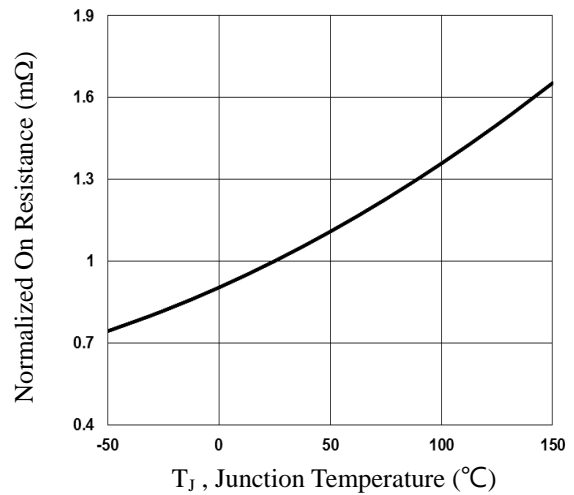


Fig.2 Normalized R_{DS(on)} vs. T_J

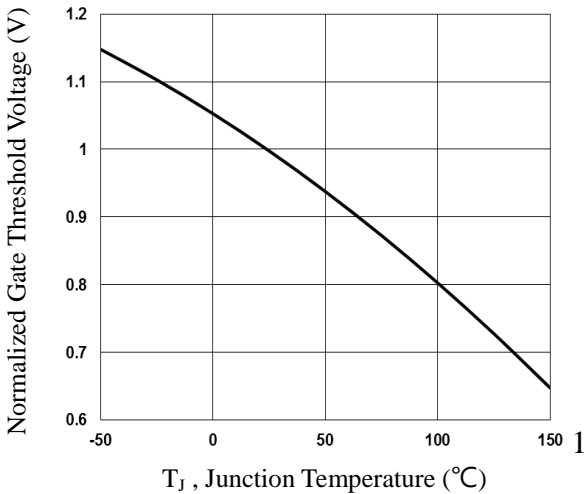


Fig.3 Normalized V_{th} vs. T_J

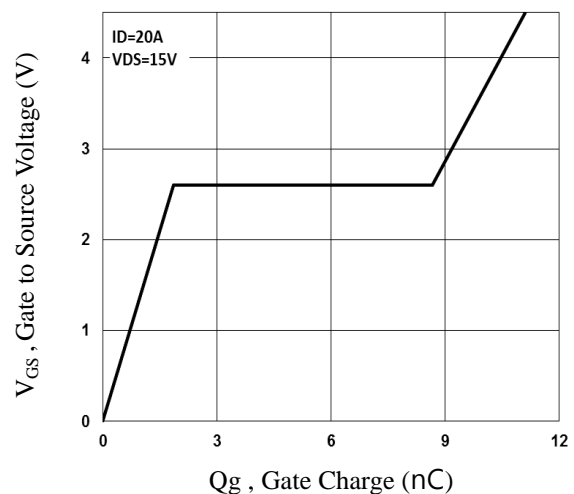


Fig.4 Gate Charge Waveform

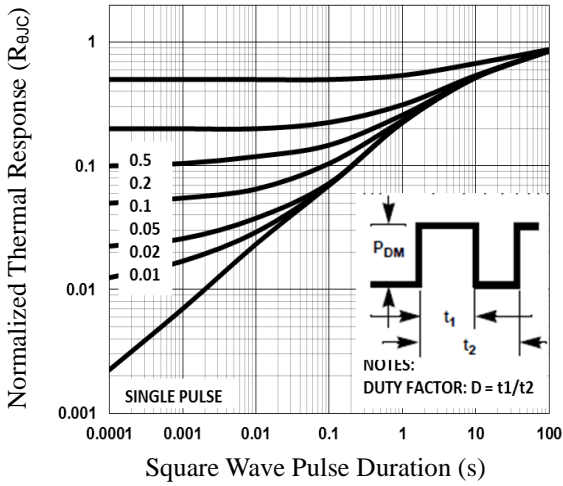


Fig. 5 Normalized Transient Impedance

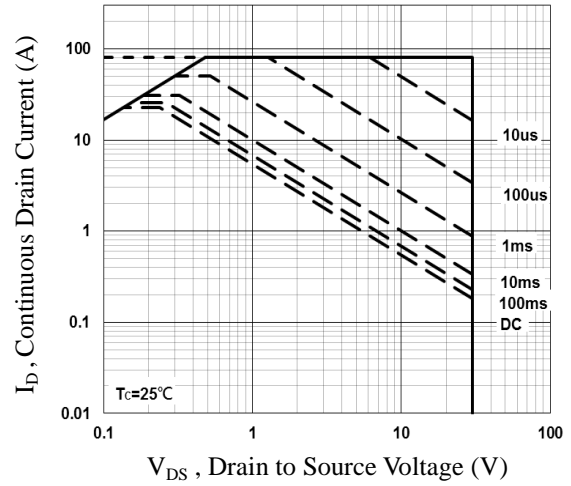


Fig. 6 Maximum Safe Operation Area

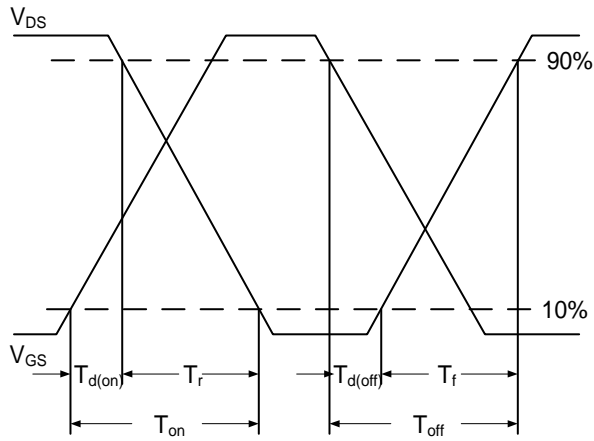


Fig. 7 Switching Time Waveform

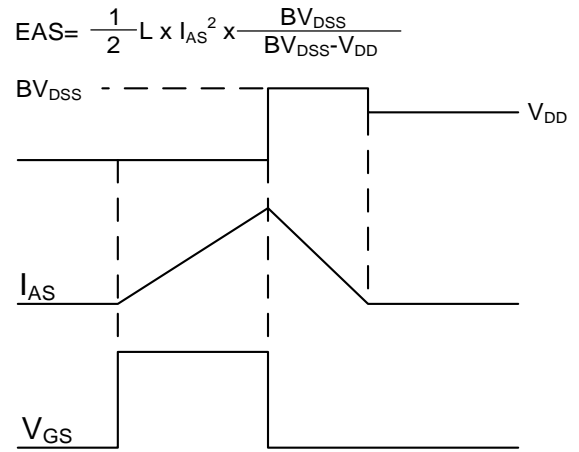


Fig. 8 EAS Waveform